

SCANSTA101 Low Voltage IEEE 1149.1 System Test Access (STA) Master

Check for Samples: [SCANSTA101](http://www.ti.com/product/scansta101#samples)

- **²• Compatible with IEEE Std. 1149.1 (JTAG) Test**
- **(SCAN Embedded Application Software** alone boundary scan tester. **Enabler) Software Rev 2.0**
- **FIRE SCANSTATOT IS AN EMAGE CORNER FOR SERVICE ASSETS AND THE SCANPSCHOLOGY**
 •• Interface: Compatible with a Wide Range of SCANFTATION SUPPORTS the JEFE 1149.1 Test
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-
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-
- **•• On-Board Compares Support Test Data In boundary scan operations. (TDI) Validation Against Preloaded Expected** The interface from the SCANSTA101 to the system
-
- **• State, Shift, and BIST Macros Allow**
- **• Operates at 3.3 V Supply Voltages with 5 V** programmable logic devices. **Tolerant I/O**
- **• Outputs Support Power-Down TRI-STATE Mode.**

¹FEATURES DESCRIPTION

The SCANSTA101 is designed to function as a test master for an IEEE 1149.1 boundary scan test **Access Port and Boundary Scan Architecture** system. It is suitable for use in embedded IEEE **• Supported by Texas Instruments' SCAN Ease** 1149.1 applications and as a component in a stand-

The SCANSTA101 is an enhanced version of, and a **Interface; Compatible with a Wide Range of** SCANSTA101 supports the IEEE 1149.1 Test Access **Processors and Processor Clock (PCLK)** Port (TAP) standard and the IEEE 1532 standard for
Frequencies in-system configuration of programmable devices in-system configuration of programmable devices.

• 16-Bit Data Interface (IP Scalable to 32-bit) The SCANSTA101 improves test vector throughput **• 2k x 32 Bit Dual-Port Memory** and reduces software overhead in the system processor. The SCANSTA101 presents a simple, **• Load-on-the-Fly (LotF) and Preloaded Vector Operating Modes Supported** research asset interface to the system processor. Texas Instruments provides C-language source code **• On-Board Sequencer Allows Multi-Vector** which can be included in the embedded system **Operations such as those Required to Load** software. The combination of the SCANSTA101 and its support software comprises a simple API for

processor is implemented by reading and writing **• 32-Bit Linear Feedback Shift Register (LFSR)** registers, some of which map to locations in the **at the Test Data In (TDI) Port for Signature** SCANSTA101 memory. Hardware handshaking and **Compression** compression interface.

Predetermined Test Mode Select (TMS) The SCANSTA101 is available as a stand-alone **Sequences to be Utilized device** packaged in a 49-pin NFBGA package. It is also available as an IP macro for synthesis in

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NSTRUMENTS

EXAS

SCANSTA101 ARCHITECTURE

* Note: IP data bus width can be configured for 16 or 32 bit applications. Silicon data bus width is fixed at 16 bits.

Figure 1. SCANSTA101 STA Master and Interfaces

[Figure](#page-1-0) 1 shows a high level view of the SCANSTA101 STA Master and its interfaces. [Table](#page-1-1) 1 provides a brief description of each of these interfaces. provides a brief description of the device pins and their functions. The device is composed of three interfaces around a dual-port memory. These interfaces are the Parallel Processor Interface (PPI), Serial Scan Interface (SSI), and Test and Debug Interface. The System Input block designates inputs that have global use across the device.

The Test and Debug Interface supports BIST, boundary scan, and internal scan for the SCANSTA101.

Table 1. INTERFACE DESCRIPTIONS

CONNECTION DIAGRAM

Figure 2. NFBGA Package Pinout (Top View)

PIN DESCRIPTIONS

(1) D(31:16) in the Parallel Processor Interface and TRST1_SM in the Serial Scan Interface are not bonded out for the packaged device. These are used in the 32-bit IP Macro Mode only.

Texas

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These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

ABSOLUTE MAXIMUM RATINGS (1)(2)

(1) Absolute maximum ratings are those values beyond which damage to the device may occur. The datasheet specifications should be met, without exception, to ensure that the system design is reliable over its power supply, temperature, and output/input loading variables. Texas Instruments does not recommend operation of SCAN STA products outside of recommended operation conditions.

(2) If Military/Aerospace specified devices are required, please contact the Texas Instruments Sales Office/ Distributors for availability and specifications.

RECOMMENDED OPERATING CONDITIONS

DC ELECTRICAL CHARACTERISTICS

Over recommended operating supply voltage and temperature ranges unless otherwise specified.

DC ELECTRICAL CHARACTERISTICS (continued)

Over recommended operating supply voltage and temperature ranges unless otherwise specified.

AC ELECTRICAL CHARACTERISTICS/OPERATING REQUIREMENTS

Over recommended operating supply voltage and temperature ranges unless otherwise specified. C_L = 50 pF, R_L = 500 Ω unless otherwise specified.

(1) Due to uncertainty in the relationship of the STB placement to the system clock, SCK, the STB may be detected during the current or the next SCK cycle.

(2) An absolute maximum delay can be calculated as: (Max # SCK) x (SCK Period) + t_D.For example, for t_{D1} (STB low to DTACK low, register write), the # SCK cycles is 2 or 3 and the delay, t_D, is 11.5ns. For a SCK with a 100ns period, the absolute maximum delay is (3 x 100ns) + 11.5, or 311.5ns.

AC ELECTRICAL CHARACTERISTICS/OPERATING REQUIREMENTS (continued)

Over recommended operating supply voltage and temperature ranges unless otherwise specified. $C_L = 50$ pF, $R_L = 500\Omega$ unless otherwise specified.

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APPLICATIONS/PROGRAMMERS REFERENCE

Table 2. REGISTER SUMMARY

Table 3. MEMORY/REGISTER ADDRESS MAP

(1) The TDI_SM LFSR result and seed registers require two sequential reads/writes for each register pair.

(2) The Index register is used to set the individual address pointers. Writing to the Index register will set each of the individual address pointers (TDO_SM, TDI_SM, Expected, and Mask). The individual address pointers will automatically increment with each long word read from TDI_SM or each long word written to the TDO_SM, Expected, or Mask memory spaces.

(3) The actual address is calculated from the base address of the memory area plus the content of its address pointer.

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Table 3. MEMORY/REGISTER ADDRESS MAP (continued)

(4) The upper two bytes of each vector are ignored. These have been inserted to make the space align on long word boundaries.

Table 4. VECTOR STRUCTURE

Table 5. HEADER/TRAILER STRUCTURE

(1) Count must be greater than zero if the Header/Trailer Usage bits are not equal to "000" or "111".

STRUMENTS

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Table 6. MACRO STRUCTURE

Table 7. HEADER/TRAILER USAGE

Table 8. Macro Type bits 10 and 11

Table 9. SEQUENCER STRUCTURE

Table 10. SCAN BRIDGE SUPPORT STRUCTURE

MODULE DESCRIPTIONS

[Figure](#page-1-0) 1 shows a high level view of the SCANSTA101. The Parallel Processor Interface (PPI) and the Serial Scan Interface (SSI) connect to each other through a dual-port memory. The PPI provides a parallel interface for transferring data into and out of the dual-port memory, and for configuring, controlling and obtaining the status of the device. The SSI, which resides on the other side of the dual-port memory, provides the parallel-to-serial and serial-to-parallel conversion paths for providing test data and test control to support the STA Master and IEEE 1532 functions.

DUAL PORT MEMORY

The Dual Port Memory module is a 2048 x 32 bit dual-port memory which acts as the buffer between the PPI and the SSI. There are seven regions of memory as viewed from the processor side. These regions, shown in [Table](#page-7-0) 3, are TDO_SM, TDI_SM, Expected, Mask, Vector, Header/Trailer, Macro. Sequencer, and ScanBridge Support. Each has a pointer which resides in the PPI.

The memory is big endian oriented and is viewed as a single entity from the SSI side, and the SSI maintains a pointer. The dual port memory module does not include any logic outside of its own macro function, so all the timing and support logic is included in the PPI and SSI sections. There is no logic included in the SCANSTA101 design to utilize the "busy" indicators to keep the user from overwriting memory locations. The only area where this could occur in memory would be the TDI_SM memory space since both the SSI and PPI can write to this space, but the drivers should not allow PPI writes to this area during normal operations. The Texas Instruments SCAN Ease software does not allow PPI writes to the TDI_SM memory.

PARALLEL PROCESSOR INTERFACE

The overall function of the PPI is to receive the parallel data from the processor; store the data in the appropriate register or memory location; act on the data if the data are PPI control data; provide status data back to the processor; and provide a read path for result data to the processor. The PPI consists of seven main blocks of logic. These blocks are the Edge Detector (ED), Processor Interface Controller (PIC), the Memory/Register Decoder (MRD), the Word/Long Word Converter (WLWC), the Control Generator (CG), the Status/Interrupt Generator (SIG) and the Flag Generator (FG).

WORD/LONG WORD CONVERTER

The Word/Long Word Converter (WLWC) has four 16-bit capture registers: a least significant/most significant (LS/MS) word read capture register pair; and a LS/MS word write capture register pair.

Each register within the write register pair has a separate enable to allow for the necessary control to accomplish word to long word conversions when in the 16-bit mode. In 32-bit mode, these enables are driven simultaneously. A mux is provided in front of the MS word write capture register to select between the 32-bit and 16-bit mode external bus.

Only one enable and a mux select is needed to control the read capture register pair to accomplish the long word to word conversions when in the 16- bit mode. In the 32-bit mode, the mux selection doesn't change, so 32 bits are always driven. A mux is on either side of the LS word read capture register. The mux at the register output provides for selection between the 32-bit and 16-bit mode. The mux at the register input is for selection between register space and memory space.

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All the control for this block is provided by the PIC and MRD with the 16/32-bit mode enable coming from the Setup register.

EDGE DETECTOR

The PPI module can support either an asynchronous or synchronous processor interface. For an asynchronous interface, the circuit initially synchronizes STB and CE to the system clock, SCK, by pipelining these two signals through two flip-flop stages and then performing an edge detection on STB and CE. For a synchronous parallel processor interface, this circuit just performs an edge detection. The outputs of this circuit, one clock wide pulses indicating the detection of negative and positive edges, are used by the Processor Interface Controller (PIC) state machine to start and to end a processor access.

PROCESSOR INTERFACE CONTROLLER

The Processor Interface Controller (PIC) monitors the incoming processor control signals and sets up the appropriate internal control signals to move the data into memory or into an internal register on a write or to move the data out of memory or out of an internal register on a read. The PIC edge detects the CE and the STB to start the access. The PIC provides the control for the word to long word conversion in the WLWC by controlling the three enables and the mux select (READ_MSW) to the capture registers. The PIC also controls when the internal read/write enable is issued to the memory to complete the read/write operation. Timing for register and memory read and write operations is described in [Figure](#page-22-0) 12 and [Figure](#page-22-1) 13.

MEMORY/REGISTER DECODER

The Memory/Register Decoder (MRD) contains all six index registers (Index, Vector Index, Header/Trailer Index, Macro Index, Sequencer Index and ScanBridge Support Index) and four address registers (TDI_SM Address, TDO_SM Address, Expected Address and Mask Address). On the PPI side, both index and address registers are used to maintain pointers to their respective memory spaces. The Index register sets values in all four address registers; i.e., writing to the Index register sets all of the address registers. The value written to each address register is the sum of its base address and the value written to the Index register (the offset). All index and address registers except the Index register auto-increment with each access to the corresponding memory space.

The MRD provides the address decode to generate all the control and status register enables for the CG and the SIG. The MRD also provides the mux selects for the register or memory selection for the read capture operation in the WLWC.

CONTROL GENERATOR

The Control Generator includes the seven control registers: the Start, Interrupt Control, Setup, Clock Divider, TDI_SM LFSR Exponent, TDI_SM LFSR LSB Seed, and TDI_SM LFSR MSB Seed registers are included in this block. The CG issues a strobe to the SSI when a write has been issued to the Start or Setup registers so the SSI can react to the new control data. The strobe is derived from edge detecting the enables to the Start or Setup registers. The "new" data to the SSI are the Use Sequencer bit and three Use Vector bits from the Start register, and the TDO Default Value, TRST, ScanBridge Support Initiate/Release, three-bit Sync Bit Length, and two Test Loop-back bits from the Setup register.

STATUS/INTERRUPT GENERATOR

The Status/Interrupt Generator comprises the four status registers plus the logic to generate the interrupts and to clear the interrupts on a read. The registers are the Status, Interrupt Status, TDI_SM LFSR LSB Result and TDI_SM LFSR MSB Result registers. The SIG receives the LFSR result and strobe signal SSI_LFSR_EN from the SSI and captures the data in the LSB and MSB registers. The SIG receives the compare result bit value from the SSI along with the compare result bit clear and the compare result bit load.

The SIG receives the 4 memory space flags from the FG along with their associated load and clear signals so these bits may be constantly updated. The half-full, half-empty, full and empty flags are generated and updated regardless of the states of their respective interrupt enables. The SIG also receives the four interrupt enables for the flags. The SIG also receives the sequencer active and the three vector active signals from the SSI. These are also updated regardless of the enable state.

If an interrupt enable is set then an interrupt will be generated. If an interrupt occurs at the same time as the interrupt status is being read, then the interrupt will be set after the read is complete. All bits in the Interrupt Status register are cleared when the register is read.

FLAG GENERATOR

The FG takes in the TDI_SM or TDO_SM pointer values from the PPI address pointers, compares them and generates the appropriate flags. If a flag condition has occurred, it is passed, along with the corresponding load enable, to the SIG to set the bit in the status register. If the flag condition changes, then the clear for the corresponding bit is passed to the SIG to clear the flag. The TDO SM empty and the TDI SM full flags are passed to the SSI also. A counter enable is passed from the SSI to indicate to the FG when the SSI's pointer value has changed. If a decrement and an increment occur at the same time to either of the counters, the counter value will not change.

PPI INTERFACE TIMING

The processor accesses to SCANSTA101 can be classified into six categories:

- register read
- register write
- 16-bit memory read
- 16-bit memory write
- 32-bit memory read
- 32-bit memory write

Register reads and register writes are performed the same whether the device is in 16-bit mode or 32-bit mode. In 32-bit mode, only the LS word is used. The MS word is ignored. The timing for the 16-bit and 32-bit modes is exactly the same.

The 16-bit mode memory write is accomplished by performing two consecutive register writes with the only difference being that the actual write occurs on the second access. The 16-bit mode register read consists of two accesses, with the first access performed similar to the 16-bit register read but requiring one more clock to complete the memory access. Since all 32-bits of the memory data are captured on the first access, the second memory read access is 2 clocks shorter than the first.

The processor initiates a write cycle by asserting \overline{CE} followed by \overline{STE} . A set time prior to asserting \overline{STE} , the R/W is driven low and the address and data buses are driven by valid address and data, respectively. After edge detecting the STB and registering all the inputs, the address is decoded to determine which internal address within the SCANSTA101 will be written by the processor. The DTACK will be asserted on the same rising edge of SCK on which the negative edge of the STB signal is detected, indicating to the processor that it can deassert the STB. When the SCANSTA101 detects the positive edge of the STB, it will deassert the DTACK indicating to the processor that it can start a new cycle. The processor can start a new cycle by asserting the STB and by driving the address and data buses with new address and data.

A read cycle is similar to the write cycle except that the DTACK will not be asserted until the selected address location's contents are loaded. So, for a 16-bit register read it takes one more clock than it does for a write cycle.

Reads and writes to the SCANSTA101 memory require two consecutive accesses in the 16-bit external bus mode. The memory writes are similar to register writes; the processor performs two consecutive 16-bit writes to write to the selected memory location.

During a memory read, the DTACK line is not asserted until the contents of the memory is loaded into the capture registers. For this reason the first read from the memory requires five clocks which includes the memory access time, while the second read is done in three clock cycles.

SERIAL SCAN INTERFACE

The Serial Scan Interface consists of the following units:

- Clock Divider and TCK_SM Control
- TAP Tracker
- Pointer Generator
- Structure (Sequencer/Vector/Macro/ScanBridge) Decoder

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- Structure (Sequencer/Vector/Macro/ScanBridge) Control Registers
- **Count Generator**
- Shifter (TDO_SM/TDI_SM/TMS_SM)
- **Comparator**
- Expected and Mask Registers
- Serial Scan Interface Controller (SSIC) and ScanBridge Controller

The clock divider unit divides the system clock SCK based on the programmable divisor set in the clock divider to generate TCK_SM. The TCK_SM control unit gates TCK_SM if the TDO_SM buffer is empty.

The TAP Tracker unit tracks the target's TAP controller state. The TAP Tracker determines whether the target's TAP controller is in SIR or SDR state, so that the necessary pad bits are inserted.

The shifter block contains two 32-bit shift registers for TDO_SM and TDI_SM respectively, and a 16-bit shift register for TMS_SM.

The comparator unit compares the serial input on the TDI_SM pin with the expected data, bit by bit, if the compare bit of the Macro Structure is set. If the compare/mask bit is set, then the comparator unit compares only those bits that are unmasked.

Expected and Mask Registers contain the data fetched from the memory. This data is used by the comparator to compare the TDI_SM input with the expected data.

The SSIC provides the timing and control signals to synchronize the operation of the various blocks in the SSI. The ScanBridge Controller consists of the control logic to set up the ScanBridge hierarchy, if the ScanBridge Support Initiate/Release bit is enabled, prior to scanning test vectors out of TDO_SM.

CLOCK DIVIDER AND TCK_SM CONTROL

The clock divider is a binary divider with only one bit of the clock divider register set to one at any given time. The SCANSTA101 SSI ignores bits 0, and 8-15 of the clock divider register, so the supported divisors are 2, 4, 8, 16, 32, 64 and 128.

To generate a TCK_SM of frequency SCK/4, the clock divider register should be set to 4 (00000100). This will enable the gate at the output of bit 2 of the counter to generate a clock of SCK divided by 4. If in LotF mode, the TCK_SM enable from the SSIC will gate TCK_SM when the TDO_SM buffer is empty.

TAP TRACKER

The TAP Tracker consists of a 16-bit register to track the IEEE Standard 1149.1 TAP state machine. The register is one-hot encoded (meaning that only one bit in the TAP tracker register, corresponding to the current TAP state, is set at a time) and will continuously track the target's TAP Controller based on the TMS_SM sequence. The TAP Tracker is used by the ScanBridge support controller to determine whether the target's TAP controller is in SIR or SDR state so that it can insert an appropriate number of pre and post-shift pad bits.

The TAP Tracker will enter Test-Logic Reset state upon setting the TRST bit (bit 5) in the Setup register or by issuing a sequence of five TMS_SM high bits.

SHIFTER

The Shifter block contains two 32-bit shift registers for TDO_SM and TDI_SM respectively, and one 16-bit shift register for TMS_SM. The TMS_SM shifter block diagram is shown in [Figure](#page-14-0) 3, the TDO_SM shifter block diagram is shown in [Figure](#page-14-1) 4, and the TDI_SM shifter block diagram is shown in [Figure](#page-14-2) 5.

Before the start of a vector processing the TMS_SM shifter is loaded with the least significant 16 bits of the macro structure. Based on the pre-shift TCK_SM count, the TMS_SM shifter will skip (7 - pre-shift count) least significant bits. e.g., if the pre-shift count is 4, the least significant 3 bits of the TMS_SM shifter will not be used to drive TMS_SM during pre-shift. Similarly, if the post-shift is less than 7 then, during post shift only the number of bits equal to the post-shift count following the macro structure bit 8 will be used to drive TMS_SM.

The SCANSTA101 memory is organized in big endian format. A memory write is accomplished by two consecutive writes to the same location. When embedded software loads the TDO_SM memory, the least significant 16 bits are written first and then the most significant 16 bits. Therefore, when the Sequencer or a Vector is initialized the SSIC can directly fetch and load the long word to the TDO_SM shifter without any modification.

Figure 5. TDI_SM Shifter

Reading from TDI_SM memory is accomplished by two consecutive reads. When reading from the TDI_SM memory, the first read will contain the least significant 16 bits and the second read the most significant 16 bits.

The TDI_SM shifter unit consists of two 32-bit shift registers as shown in [Figure](#page-14-2) 5. The shift register on top in the figure is the LFSR register. Before using the TDI_SM LFSR register, the LFSR Exponent and LFSR Seed registers must be written with valid data. The LFSR Exponent register must be written with a 3-bit binary encoded value that selects one of the five available polynomials. The value written to the LFSR Seed registers is used to initialize the TDI_SM LFSR register to a predetermined state. Once the test vector has completely scanned in, the final contents of the LFSR register are transferred to the LFSR Result registers.

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The 32-bit shift register at the bottom is used to shift in TDI_SM directly in normal mode or to shift in TMS_SM or TDO_SM in the loop-back mode. After each long word of 32 bits is shifted into this register, the contents of the register are transferred to the corresponding TDI memory location before the next shift operation.

SHIFTER IMPLEMENTATION

Shift register implementation is illustrated in [Figure](#page-15-0) 6. Shift out enable for the TMS_SM and TDO_SM shifters is generated by comparing the clock pulse counter output to the clock divider - 1. Shift in enable for the TDI_SM shifter is generated by comparing the clock pulse counter to the programmable divisor/2 - 1. These enables are gated by the control signals from SSIC so that data are shifted out (TMS_SM/TDO_SM) or shifted in (TDI_SM) only when necessary.

COMPARATOR AND EXPECTED/MASK REGISTERS

The One-Bit Comparator, when enabled, compares the TDI_SM input with expected data. When the compare feature is enabled (in preloaded vector mode only) the SSIC pre-fetches data into Expected and Mask registers from the address locations for the current vector being processed. The comparator will compare each bit on the TDI SM input with the corresponding bit from the expected register. If the mask feature is enabled, then the comparison is performed only on those bits that are not masked, i.e., on those bits for which the mask is set to zero. [Table](#page-16-0) 11 shows how the Compare and Use Mask/Compare bits in the Macro Structure are used.

Table 11. Compare and Use Mask/Compare Bit Descriptions

The Results of Compare bit (bit 15 of Status register) stores the comparison results in the status register. This bit defaults to fail (zero) and will be updated only after the current vector is processed. In the case of a single vector the Results of Compare bit will be set to one (pass) only if all the bits in the scanned in vector match the expected vector. However, in the case of the sequencer only the results of final vector comparison will be taken into account.

Each vector within the sequencer is repeated until the vector repeat count is exhausted. The sequence is repeated until the sequencer repeat count is exhausted.

[Figure](#page-16-1) 7 illustrates the compare logic.

After reset and before every sequencer process, flip-flops 1 and 3 are initialized to zero while flip-flop 2 is set to 1. When the compare feature is enabled flip-flop 1 is continuously updated with the immediate comparison results (1 for pass and 0 for fail). Flip-flop 2 is reset to zero when a mismatch occurs and remains in this state for the remainder of the current vector processing. When the current vector is completely processed flip-flop 3 (Results of Compare register) will be updated with the current status.

Figure 7. Compare Logic

SERIAL SCAN INTERFACE CONTROLLER AND SCANBRIDGE CONTROLLER

The Serial Scan Interface Controller (SSIC) remains in the Idle state until new data are written to the Start register. When this event occurs the following operations are performed:

- 1. If the ScanBridge Support Initiate/Release bit was not set previously and is currently set in the Setup register, the SSIC initializes the ScanBridge Controller (SBC) to perform the following steps to set up all ScanBridges in the hierarchy.
	- (a) Determine the number of levels of ScanBridge support to be inserted (from the ScanBridge support structure)
	- (b) Sequence TMS_SM so that all ScanBridges in the same level of hierarchy enter the SIR state, and then shift in the address (from the ScanBridge structure) to select a ScanBridge in the current level of hierarchy. The ScanBridge's TAP controller is then sequenced through the Update-IR state.
	- (c) Sequence TMS_SM so that the selected ScanBridge's TAP controller enters the SIR state, then scan in the MODESEL instruction to put its mode register in the data path.
	- (d) Sequence the selected ScanBridge's TAP controller to enter the Shift-DR state and scan in the LSP contents (from the ScanBridge structure) into its mode register. The ScanBridge's TAP controller is then sequenced through the Update-DR state.
	- (e) Repeat Step 1C, but this time scan in the UNPARK instruction so that the LSP is inserted into the active scan chain.
	- (f) Sequence the ScanBridge's TAP controller to enter the RTI state (the LSP will not be unparked until its TAP controller enters RTI).
	- (g) Repeat Steps 1B through Step 1G to configure the ScanBridges in the remaining hierarchy levels. One set of pre-shift pad and post-shift pad bits is added to the patterns for each hierarchy level between the STA Master and the ScanBridge being configured. The pad bits are used to bypass the intermediate levels of hierarchy.
	- (h) For the subsequent vectors, if the TAP Tracker enters the
		- (a) SDR state, the SCANSTA101 will add one pre-shift bit for the pad register and one post-shift bit for the bypass register for each level of hierarchy.
		- (b) SIR state, the SCANSTA101 will add one pre-shift bit for the pad register and eight post-shift bits for the ScanBridge instruction register for each level of hierarchy. The eight post-shift bits will be all ones, forcing the ScanBridge into bypass mode.
	- (i) The pad bits need to be stripped when loading a vector into TDI_SM. This will be done by having a status flag to indicate whether the vector that is being scanned out has ScanBridge support or not. If the scanned-out vector has ScanBridge support, then the pad bits will be stripped when the TAP Tracker enters the SDR or SIR states.
- 2. If the ScanBridge Support Initiate/Release bit was set previously and is currently reset in the Setup register, the SSIC will toggle TCK_SM five times while TMS_SM is held high. This will return all selected ScanBridges to the wait-for-address state and park the LSPs in the Test-Logic-Reset state. When the ScanBridge support is released the user should make sure that the Use Vector and Use Sequencer bits in the Start register are not set, so that the SSIC will not start processing a vector or the sequencer immediately after releasing the ScanBridge support. Once the ScanBridge support is released the user may start processing a vector or the sequencer by writing to the Start register.
- 3. If the sequencer is enabled (the Use Sequencer bit in the Start register is one),
	- (a) Clear the Results of Compare bit and set the Using Sequencer bit in the Status register.
	- (b) Fetch the sequence repeat count.
	- (c) If the sequence repeat count is zero, the sequence is complete so reset the Using Sequencer bit and return to the Idle state, otherwise fetch the next vector number and its repeat count.
	- (d) If the vector number is zero, decrement the sequence repeat count and return to Step 3C. If the vector number is illegal, i.e., other than 001, 010, 011, or 100, decrement the sequence repeat count and return to Step 3C.
	- (e) If the vector repeat count is equal to zero, fetch the next vector number and its repeat count and go to Step 3D. If the repeat count is non-zero fetch the vector structure.
	- (f) If the pre-load bit in the vector structure is not set, reset the Using Sequencer bit and return to the Idle state.
- 4. If the sequencer is not enabled but a vector is enabled (the Use Vector bits in the Start register are nonzero), fetch the current vector structure and set the appropriate Using Vector bits in the Status register. If neither the sequencer nor a vector is enabled, return to the Idle state.
- 5. Fetch the Macro Structure to be used, set the vector/macro control bits and store the TMS_SM bits in the

Structure Control registers.

- 6. If the Pre-shift TCK_SM Count is not zero, then enable TCK_SM and drive TMS_SM using the first seven bits of the macro until the Pre-shift TCK_SM Count is zero. During pre-shift, TDO_SM will be driven with its previous value.
- 7. If the macro type is State then,
	- (a) If the Macro Structure Bit 7 is enabled, set TMS_SM to the bit 7 value of the macro structure and drive TDO_SM with its previous value.
	- (b) If the Macro Structure Bit 8 is enabled, set TMS_SM to the bit 8 value of the macro structure and drive TDO_SM with it's previous value and then go to Step 10.
	- (c) If the sequencer is being used, then decrement the vector repeat count and return to Step 3E. If a vector is being used, return to the Idle state.
- 8. If the macro type is BIST then,
	- (a) If the Macro Structure Bit 7 is enabled, set the count length, set TMS_SM to the bit 7 value of the macro structure and drive TDO_SM with the default value (Setup register bit 6) until the count length is zero.
	- (b) If the Macro Structure Bit 8 is enabled, set TMS_SM to the bit 8 value of the macro structure and drive TDO_SM with the default value (Setup register bit 6) and then go to Step 10.
	- (c) If the sequencer is being used then, decrement the vector repeat count and return to Step 3E. If a vector is being used, return to the Idle state.
- 9. If the macro type is Shift or Shift with Capture then,
	- (a) If the macro type is Shift with Capture, enable TDI capture.
	- (b) If the Sync Bit Support Enable bit is set, fetch sync bit count, set the count length, set TMS_SM to the loop bit and drive the TDO_SM high until sync bit count is zero.
	- (c) If the ScanBridge Support Initiate/Release bit is set, drive the TDO_SM with pre- PAD bit (high) and while TMS SM remains set to the loop bit. Repeat for each level of hierarchy.
	- (d) If the Use Data/Instruction Header is enabled, fetch the header length and data, set the count length, and drive the TDO_SM with header data until the header length is zero and while TMS_SM remains set to the loop bit.
	- (e) If the Compare or Mask/Compare is set, enable the comparator.
	- (f) Set the vector count length, and drive the TDO_SM with vector data until the count length is one and while TMS, SM remains set to the loop bit. In the LotF mode if the count length is not zero and the TDO buffer is empty, then gate TCK_SM until more data are available in the TDO buffer. When TCK_SM is disabled TMS SM and TDO SM will be driven with their previous values.
	- (g) If the Use Data/Instruction Trailer is enabled, fetch the trailer length and data, set the count length, and drive TDO_SM with trailer data until the trailer length is one and while TMS_SM remains set to the loop bit.
	- (h) If the ScanBridge Support Initiate/Release bit is set:
		- (a) If the TAP tracker is in the Shift-IR state and the number of levels of hierarchy is greater than one, set the count length to eight, and drive TDO_SM with post-shift pad bits (all high) until the count length is zero for each level of hierarchy and while TMS_SM remains set to the loop bit.
		- (b) If the TAP tracker is in the Shift-DR state and the number of levels of hierarchy is greater than one, drive TDO SM with a post-shift pad bit (high) for each level of hierarchy and while TMS SM remains set to the loop bit.
		- (c) For the final level of hierarchy or if there is only one level of hierarchy, and if the TAP tracker is in the Shift-IR state, set the count length to eight, and drive TDO_SM with post-shift pad bits (all high) until the count length is one and while TMS_SM remains set to the loop bit.
	- (i) If the Sync Bit Support Enable is set, fetch sync bit count, set the count length, and drive the TDO_SM high until sync bit count is one and while TMS SM remains set to the loop bit.
	- (j) Set TMS_SM to bit 8 of the TMS_SM Macro Structure sequence and drive TDO_SM with the final vector bit or trailer bit or post-shift pad bit or sync bit. After shifting out the final vector bit, disable the comparator and register the comparison results.
- 10. If the post-shift TCK_SM Count is not zero, then enable TCK_SM and drive TMS_SM using the last seven bits of the macro until the post-shift TCK_SM Count is zero.
- 11. If the Sequencer is being used,
	- (a) Decrement the sequence repeat count and return to Step 3C if the Compare or Mask/Compare is enabled and the results of compare is a fail.
	- (b) Decrement the vector repeat count and return to Step 3E if the if the Compare or Mask/Compare is enabled and the results of compare is a pass.

- (c) Decrement the vector repeat count and return to Step 3E if the Compare or Mask/ Compare is not enabled.
- 12. If the Vector is being used return to the Idle state.

MODE REGISTER WRITE TO VECTOR/SEQUENCER START

[Figure](#page-19-0) 8 shows the timing from the processor write to the start of vector processing. [Figure](#page-19-1) 9 shows the timing from the processor write to the start of sequencer processing. A processor write to the Start registers is indicated by a "new data" pulse. On the same SCK rising edge when the "new data" is detected to be high, the Start or Setup register contents will be updated with new data. So, the decoding of the enables takes place during the next clock cycle to determine whether to process the sequencer or a vector. Therefore, one clock after the "new data" is detected, the SSIC starts loading the pointer register on consecutive cycles with the appropriate addresses to fetch the Sequencer, Vector and Macro Structures. Once the headers are decoded and Structure Control Registers are set up, the SSIC loads the pointer register so that data from the TDO_SM memory area is fetched and loaded into the TDO_SM shifter before being shifted out. However if there are any sync bits and/or header bits and/or ScanBridge support is enabled, then the sync bits and/or header bits and/or ScanBridge pre-PAD bits will be loaded into the TDO_SM shifter before processing the actual test vector. Once the actual test vector is completely shifted out, again depending on the ScanBridge support and/or the use of trailers, post-PAD bits and the trailer bits are loaded and shifted out through the TDO_SM shifter.

The count length will be decremented by one with each shift. After shifting out all the current shifter contents the shifter will be loaded with new data before the falling edge of the next TCK_SM, if the count length is not exhausted. In the case where data cannot be loaded from the memory before the next falling edge of TCK_SM, the TCK_SM will be gated until the data is available.

Figure 8. Timing from Mode Register Write to Vector Start

WRITING AND READING PARTIAL LONG WORDS

Care should be taken when writing a partial long word to TDO_SM memory or reading a partial long word from TDI_SM memory. Since the TDO_SM shifter shifts out LSB first, the valid (meaningful) bits within a partial long word *(i.e., long word containing less than 32 valid bits to be shifted to the scan chain) must be stored and written* into the memory as the least significant bits. This will assure that the desired bits will be accurately loaded into the TDO_SM shifter and shifted out to the boundary scan chain. For instance, to shift a 3-bit (110) sequence the partial long word should be written to the TDO_SM memory as shown in [Figure](#page-20-0) 10 (only the least significant 16 bits are shown). A subsequent enable and load of the vector structure with the correct length will initialize the shift operation and only the bits that are significant will be shifted out to the scan chain.

Figure 10. Writing a Partial Long Word to the TDO_SM Memory

Data is shifted from the scan chain into the TDI_SM shifter from MSB to LSB. Consequently, the valid (meaningful) bits in a partial long word shifted into the TDI_SM shifter will reside in the upper significant bit locations. For example, if a scan operation involves shifting and evaluating 69 bits returning to TDI_SM, the TDI_SM memory will be loaded with two long words (i.e., two full long words plus a partial long word containing 5 meaningful bits). If the last 5 bits shifted back to the TDI_SM shifter are 11010, then upon completion of the shift operation, the TDI SM shifter will contain the following partial long word as shown in [Figure](#page-20-1) 11 (only the most significant 16 bits are shown), which will subsequently be loaded into the TDI_SM memory.

Following a read of a partial long word, the embedded test software must adjust the position of the valid bits read from the TDI SM shifter/buffer or the position of the expected data to assure that an accurate comparison is made (and the non-meaningful bits are masked).

TDO_SM IMPLEMENTATION

The behavior of the TDO_SM output depends on the macro type that is being processed and the SETUP register bits 11 and 10, as shown in [Table](#page-20-2) 12, regardless of the TAP tracker state. For shift macros, the TDO_SM output also depends on the current macro structure's TMS_SM bit number as explained below.

(1) Default TDO value (bit 6 of the SETUP register) may be set to a 0 when SETUP[11:10]=01 and to a 1 when SETUP[11:10]=10.

For BIST and STATE macros, the TDO_SM output behaves as shown in the above table.

For the shift macros, with or without capture, the TDO_SM output behaves as per the table only when the corresponding TMS_SM output is not driven by the macro structure bit 7 or 8. On each falling edge of the TCK_SM following the TCK_SM falling edge on which the TMS_SM changes state from bit 6 of the macro structure to bit 7 of the macro structure, the serial test vector data fetched from the memory is presented on the TDO_SM output. On the falling edge of the TCK_SM on which the final bit of the test vector is presented on the TDO_SM output, the TMS_SM is presented with macro structure bit 8. On the subsequent TCK_SM falling edges, and on the TCK_SM falling edges before the TMS_SM changes state from bit 6 to bit 7 of the macro structure, the TDO SM will behave as per the table above.

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HARDWARE INTERFACE DETAILS

Table 13. System Interface Signal Description

Table 15. Serial Scan Interface Signal Descriptions

Figure 12. PPI Write Cycle Timing Diagram

Figure 13. PPI Read Cycle Timing Diagram

Figure 14. SSI Timing Diagram with Clock Divider set to 4

EXAS STRUMENTS

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Figure 15. SSI Timing Diagram with Clock Divider set to 8

SAFE MODE

This device implements the following design rules to provide Single Event Upset/Single Event Error (SEU/SEE) protection:

- Triple modular redundancy (TMR) for TRST0_SM and TRST1_SM outputs with the help of a TMR D flip-flop .
- After reset all scan interface outputs are driven to SEU tolerant safe values as shown below:
	- $-$ TMS_SM = 1
	- $-$ TCK_SM = 0
	- $-$ TDO_SM = high-Z
	- $-$ TRST0 SM = 0
	- $-$ TRST1 SM = 0
- The EXTEST and the HIGHZ outputs from the JTAG TAP controller are gated with TRST to protect the boundary scan cells from inadvertently entering the test mode.

CLOCK GENERATION AND DISTRIBUTION

Input Clock (SCK): Up to 66 MHz

Output Clock (TCK_SM): TCK_SM is a divided, registered version of SCK.

- Selectable: to 1/2, 1/4, 1/8, 1/16, 1/32, 1/64, and 1/128 of SCK.
- Frequency: up to 25 MHz

RESET STRATEGY

The incoming external hardware reset (RST) will be synchronized to the incoming clock (SCK) and is combined with the soft reset to generate a synchronized internal reset (SYS_RST_N). During operation, the chip can be reset by writing a '1' to the Reset bit in the Setup register. All logic throughout the device will be initialized, all control and status registers will be in a known default state, all PPI memory address pointers will default to their respective base addresses, the SSI memory pointer will default to zero, the Tap Tracker will be reset to TLR, and the clock division counter will be initialized to all zeroes after deassertion of the internal reset. The Reset bit in the Setup register is self clearing. The TRST bit in the Setup register, when set, resets the SSI logic and drives the TRST0_SM and TRST1_SM to zero.

SOFTWARE INTERFACE DETAILS

REGISTER DEFINITIONS

The following sections include descriptions of each addressable register in the ScanMaster memory space. Following the title of the particular register, the mnemonic for the register is included in parentheses as well as the physical address location in hexadecimal notation (value preceded by \$). **KEY**- RO: Read Only; RW: Read/Write.

Table 17. Start Register (START) (\$00)

(1) Reserved Use Vector x for future growth for the number of vectors.

Table 18. Status Register (STATUS) (\$01) (1)

(1) Write capability to the register is only for test and debug purposes. Drivers should disable writes to the register during normal operation. (2) Results of Compare bit is toggled after a compare is complete and it is set to the mismatch state when sequencer is kicked off again.

Remains in last state until next compare completed or until set to the mismatch state.

(3) Half full or half empty designates 56 long words.

(4) Reserved Using Vector x for future growth for the number of vectors.

Table 19. Interrupt Control Register (INTCTRL) (\$02)

(1) Half full or half empty designates 56 long words.

(2) Drivers should not allow Sequencer Interrupt Enable and Vector x Interrupt Enable to be set at same time. Sequencer Interrupt Enable has priority over the Vector x Interrupt Enable.

(3) Reserved Vector x Interrupt Enable for future growth for the number of vectors.

Table 20. Interrupt Status Register (INTSTAT) (\$03) (1)

(1) This register is writable in debug mode only.

(2) Half full or half empty designates 56 long words.

(3) Reserved Vector x Interrupt for future growth for the number of vectors.

(4) Drivers shouldn't allow Sequencer Interrupt and Vector x Interrupt to be set at same time. Sequencer Interrupt has priority over the Vector x Interrupt.

Table 21. Setup Register (SETUPR) (\$04)

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Table 22. Clock Divider Register (CLKDIV) (\$05)

(1) LSB of the Clock Divider register is hard coded to zero.

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Table 23. TDI_SM LFSR Exponent Register (EXPR) (\$07)

Table 24. TDI_SM LFSR LSB Seed Register (LSSEDR) (\$08) (1)(2)

(1) LSW LFSR Seed<15:0> is the LS word of the LFSR seed.

(2) This register along with register MSSEDR form a register pair and should be read/written with two consecutive read/write accesses.

Table 25. TDI_SM LFSR MSB Seed Register (MSSEDR) (\$09) (1)(2)

(1) MSW LFSR Seed <15:0> is the MS word of the LFSR seed.

(2) This register along with register LSSEDR form a register pair and should be read/ written with two consecutive read/write accesses.

Table 26. TDI_SM LFSR LSB Result Register (LSRESR) (\$0A) (1)(2)

(1) LSW LFSR Result<15:0> is the LS word of the LFSR result.

(2) This register along with register MSRESR form a register pair and should be read/written with two consecutive read/write accesses.

Table 27. TDI_SM LFSR MSB Result Register (MSRESR) (\$0B) (1)(2)

(1) MSW LFSR Result<15:0> is the MS word of the LFSR result.

(2) This register along with register LSRESR form a register pair and should be read/ written with two consecutive read/write accesses.

Table 28. Index Register (INDEXR) (\$0C) (1)(2)(3)

(1) Index<15:0> sets the individual address memory pointer.

(2) Address memory pointer must be on a long word boundary.

(3) Writing to this register sets the TDO_SM, TDI_SM, Expected and Mask pointers. These pointers will automatically increment with each long word read from the TDI_SM space and each long word write to the other TDO_SM, Expected and Mask spaces.

Table 29. Vector Index Register (VINDEXR) (\$11) (1)(2)

(1) Vector Index<15:0> sets the Vector address memory pointer.

(2) Address memory pointer must be on a long word boundary.

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Table 30. Header/Trailer Index Register (HTINDEXR) (\$13) (1)(2)

(1) Header/Trailer Index<15:0> sets the Header/Trailer address memory pointer.

(2) Address memory pointer must be on a long word boundary.

Table 31. Macro Index Register (MINDEXR) (\$15) (1)(2)

(1) Macro Index<15:0> sets the Macro address memory pointer.

(2) Address memory pointer must be on a long word boundary.

Table 32. Sequencer Index Register (SINDEXR) (\$17) (1)(2)

(1) Sequencer Index<15:0> sets the Sequencer address memory pointer.

(2) Address memory pointer must be on a long word boundary.

Table 33. ScanBridge Support Index Register (BSINDEXR) (\$19) (1)(2)

(1) ScanBridge Index<15:0> sets the ScanBridge Support address memory pointer.

(2) Address memory pointer must be on a long word boundary.

TESTABILITY DETAILS - IEEE 1149.1 SUPPORT

Table 34. Supported IEEE 1149.1 Instruction Set

Table 35. IDCODE Register Description

BIST SUPPORT

The memory BIST can be initiated through JTAG interface using the RUNBIST instruction or by setting the Onboard Memory BIST bit in the Start register. When the memory BIST is initiated through the JTAG interface the result of pass/fail will be set in the Memory BIST Result bit in the Status register and also in the BIST status register that can be accessed through the JTAG interface. The BIST status register is a one bit register and is connected in the serial path of TDO and TDI when the RUNBIST instruction is scanned into the instruction register. Once the BIST is done, the contents of the BIST status register can be scanned out to determine whether the memory BIST passed or failed. If the memory BIST is initiated through the Onboard Memory BIST bit in the Start register the result of pass/fail will be set only in the BIST Result bit in the status register. The memory BIST will initialize the memory to zero.

REVISION HISTORY

April, 2013 – Changed layout of National Data Sheet to TI format.

January, 2010 – [Applications](#page-7-1) information updates and clarification. No specification changes.

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PACKAGING INFORMATION

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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TAPE AND REEL INFORMATION

ISTRUMENTS

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE

PACKAGE MATERIALS INFORMATION

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TEXAS NSTRUMENTS

TRAY

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Chamfer on Tray corner indicates Pin 1 orientation of packed units.

*All dimensions are nominal

MECHANICAL DATA

NZA0049A

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